

Search Notes



Application/Control No.

10/697,428

Examiner

Brian S. Kwon

Applicant(s)/Patent under Reexamination

VERLAAN ET AL.

Art Unit

1614

SEARCHED

Class	Subclass	Date	Examiner
514	300	11/25/5	(L)
	23		
	51		
	249		
	561		
	565		
	562		
	488		
	486		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
ref. 09/70773	11/25/5	(L)
SHL 68f		
continuity dth		
Invent name		
Benh		